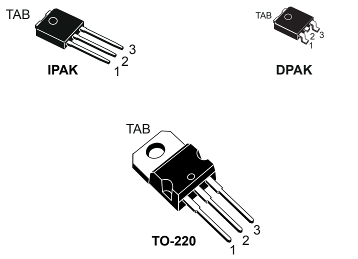
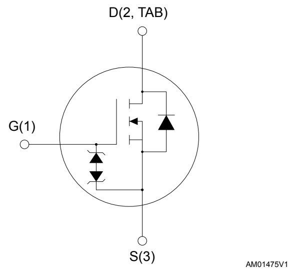
STD2NK100Z, STP2NK100Z, STU2NK100Z

Datasheet

N-channel 1000 V, 6.25 Ω typ., 1.85 A SuperMESH™ Power MOSFETs in DPAK, TO-220 and IPAK packages





Product status link
STD2NK100Z
STP2NK100Z
STU2NK100Z

Features

Order code	V_{DS}	$R_{DS(on)}$ max.	I_D	Package
STD2NK100Z	1000 V	8.5 Ω	1.85 A	DPAK
STP2NK100Z				TO-220
STU2NK100Z				IPAK

- Extremely high dv/dt capability
- 100% avalanche tested
- Gate charge minimized
- Very low intrinsic capacitance
- Zener-protected

Applications

- Switching applications

Description

These high-voltage devices are Zener-protected N-channel Power MOSFETs developed using the SuperMESH™ technology by STMicroelectronics, an optimization of the well-established PowerMESH™. In addition to a significant reduction in on-resistance, these devices are designed to ensure a high level of dv/dt capability for the most demanding applications.

1 Electrical ratings

Table 1. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{DS}	Drain-source voltage	1000	V
V_{GS}	Gate-source voltage	±30	V
I_D	Drain current (continuous) at T_C = 25 °C	1.85	A
I_D	Drain current (continuous) at T_C = 100 °C	1.16	A
I_{DM} (1)	Drain current (pulsed)	7.4	A
P_{TOT}	Total dissipation at T_C = 25 °C	70	W
ESD	Gate-source human body model (C = 100 pF, R =1.5 kΩ)	3	kV
dv/dt (2)	Peak diode recovery voltage slope	2.5	V/ns
T_j	Operating junction temperature range	-55 to 150	°C
T_{stg}	Storage temperature range		

1. *Pulse width limited by safe operating area.*
2. *$I_{SD} \leq 1.85$ A, di/dt ≤ 200 A/µs, V_{DD} = 80% $V_{(BR)DSS}$.*

Table 2. Thermal data

Symbol	Parameter	Value			Unit
		DPAK	TO-220	IPAK	
$R_{thj\text{-}case}$	Thermal resistance junction-case	1.79			°C/W
$R_{thj\text{-}pcb}$ (1)	Thermal resistance junction-pcb	50	-	-	
$R_{thj\text{-}amb}$	Thermal resistance junction-ambient		62.5	100	

1. *When mounted on FR-4 board of 1 inch², 2 oz Cu.*

Table 3. Avalanche characteristics

Symbol	Parameter	Value	Unit
I_{AR} (1)	Avalanche current, repetitive or not-repetitive	1.85	A
E_{AS} (2).	Single pulse avalanche energy	170	mJ

1. *Pulse width limited by T_{jmax}.*
2. *Starting T_j = 25°C, I_D = I_{AR}, V_{DD} = 50 V*

2 Electrical characteristics

(T_{CASE} = 25 °C unless otherwise specified)

Table 4. On/off states

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	V_{GS} = 0 V, I_D = 1 mA	1000			V
I_{DSS}	Zero gate voltage drain current	V_{GS} = 0 V, V_{DS} = 1000 V			1	µA
		V_{GS} = 0 V, V_{DS} = 1000 V, T_C = 125 °C [(1)]			50	µA
I_{GSS}	Gate-body leakage current	V_{DS} = 0 V, V_{GS} = ±30 V			±10	µA
$V_{GS(th)}$	Gate threshold voltage	V_{DS} = V_{GS}, I_D = 50 µA	3	3.75	4.5	V
$R_{DS(on)}$	Static drain-source on resistance	V_{GS} = 10 V, I_D = 0.9 A		6.25	8.5	Ω

1. *Defined by design, not subject to production test.*

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
C_{iss}	Input capacitance	V_{DS} = 25 V, f = 1 MHz, V_{GS} = 0 V	-	499	-	pF
C_{oss}	Output capacitance			53		
C_{rss}	Reverse transfer capacitance			9		
$C_{oss\ eq.}$ [(1)]	Equivalent output capacitance	V_{GS} = 0 V, V_{DS} = 0 V to 800 V	-	28	-	pF
R_G	Gate input resistance	f = 1 MHz, open drain	-	6.6	-	Ω
Q_g	Total gate charge	V_{DD} = 800 V, I_D = 1.85 A, V_{GS} = 0 to 10 V (see Figure 16. Test circuit for gate charge behavior)	-	16	-	nC
Q_{gs}	Gate-source charge			3		
Q_{gd}	Gate-drain charge			9		

1. *$C_{oss\ eq.}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS}increases from 0 to 80% V_{DSS}.*

Table 6. Switching times

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$	Turn-on delay time	V_{DD} = 500 V, I_D = 0.9 A, R_G = 4.7 Ω, V_{GS} = 10 V (see Figure 15. Test circuit for resistive load switching times and Figure 20. Switching time waveform)	-	7.2	-	ns
t_r	Rise time			6.5		
$t_{d(off)}$	Turn-off delay time			41.5		
t_r	Fall time			32.5		

Table 7. Source-drain diode

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
I_{SD}	Source-drain current		-		1.85	A
I_{SDM} (1)	Source-drain current (pulsed)		-		7.4	A
V_{SD} (2)	Forward on voltage	I_{SD} = 1.85 A, V_{GS} = 0 V	-		1.6	V
t_{rr}	Reverse recovery time	I_{SD} = 1.85 A, di/dt = 100 A/µs	-	476		ns
Q_{rr}	Reverse recovery charge	V_{DD} = 60 V	-	1.6		µC
I_{RRM}	Reverse recovery current	(see Figure 17. Test circuit for inductive load switching and diode recovery times)	-	6.9		A
t_{rr}	Reverse recovery time	I_{SD} = 1.85 A, di/dt = 100 A/µs	-	532		ns
Q_{rr}	Reverse recovery charge	V_{DD} = 60 V, T_j = 150 °C	-	1.9		µC
I_{RRM}	Reverse recovery current	(see Figure 17. Test circuit for inductive load switching and diode recovery times)	-	88		A

1. *Pulse width is limited by safe operating area.*
2. *Pulsed: pulse duration = 300 µs, duty cycle 1.5%.*

Table 8. Gate-source Zener diode

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)GSO}$	Gate-source breakdown voltage	I_{GS} = ±1 mA, I_D = 0 A	30	-	-	V

The built-in back-to-back Zener diodes are specifically designed to enhance the ESD performance of the device. The Zener voltage facilitates efficient and cost-effective device integrity protection, thus eliminating the need for additional external componentry.

2.1 Electrical characteristics (curves)

Figure 1. Safe operating area for IPAK, DPAK

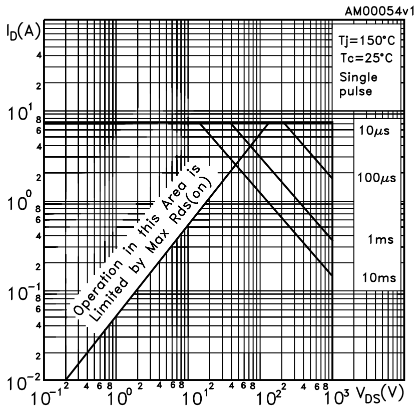


Figure 2. Thermal impedance for IPAK, DPAK

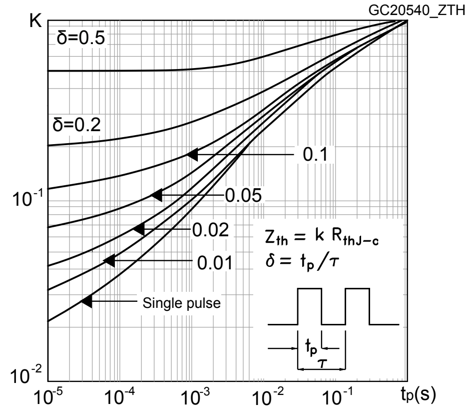


Figure 3. Safe operating area for TO-220

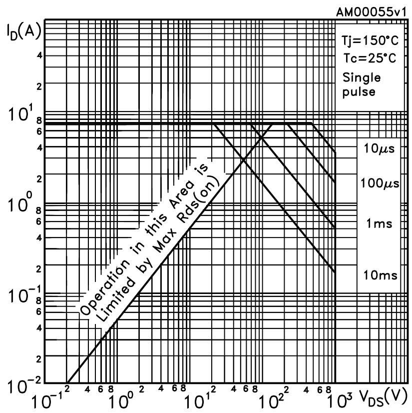


Figure 4. Thermal impedance for TO-220

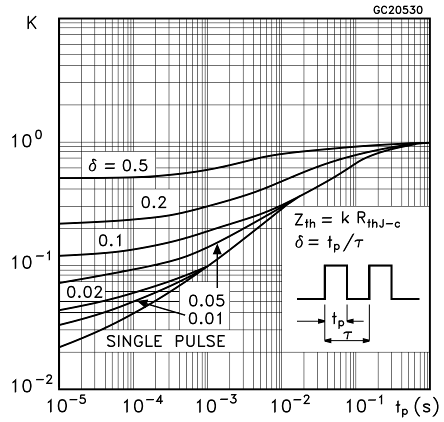


Figure 5. Output characterisics

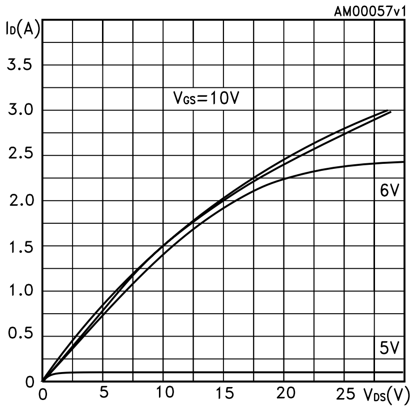


Figure 6. Transfer characteristics

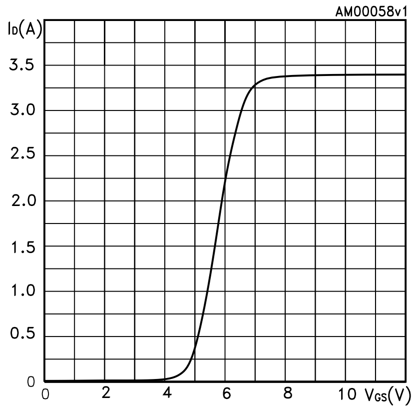


Figure 7. Normalized $V_{(BR)DSS}$ vs temperature

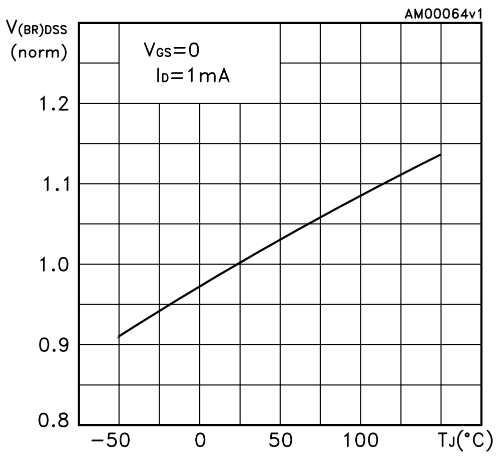


Figure 8. Static drain-source on resistance

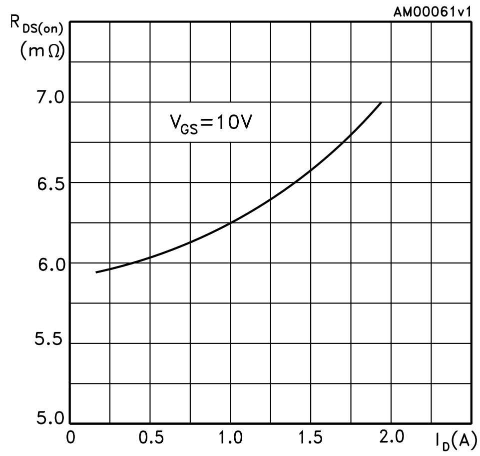


Figure 9. Gate charge vs gate-source voltage

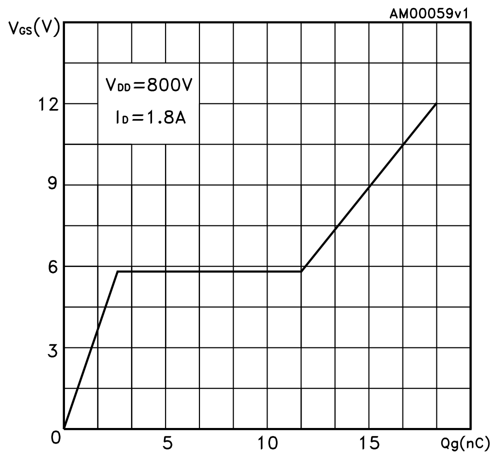


Figure 10. Capacitance variations

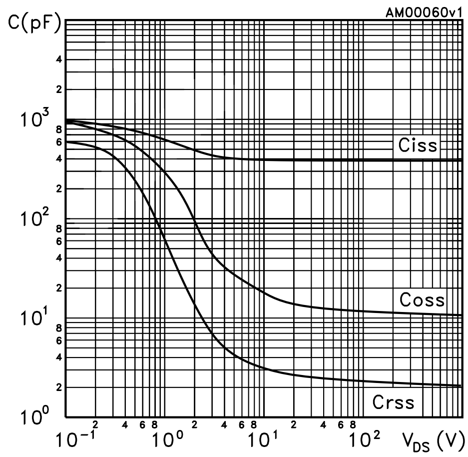


Figure 11. Normalized gate threshold voltage vs temperature

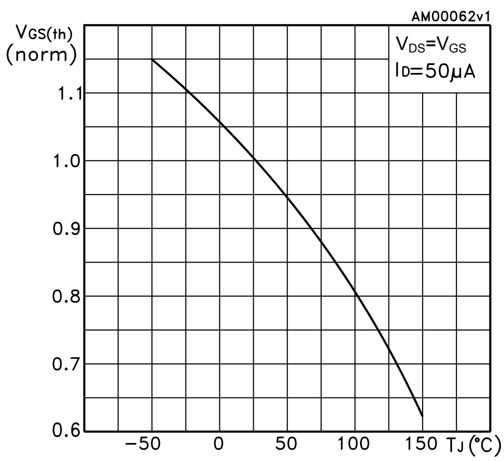
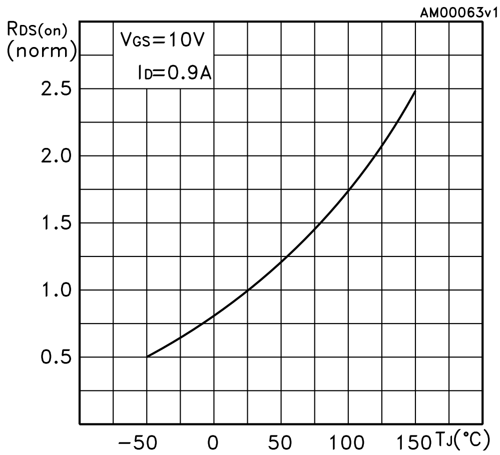


Figure 12. Normalized on resistance vs temperature



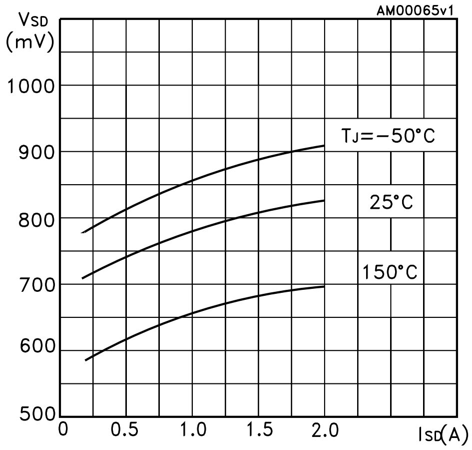


Figure 13. Source-drain diode forward characteristics

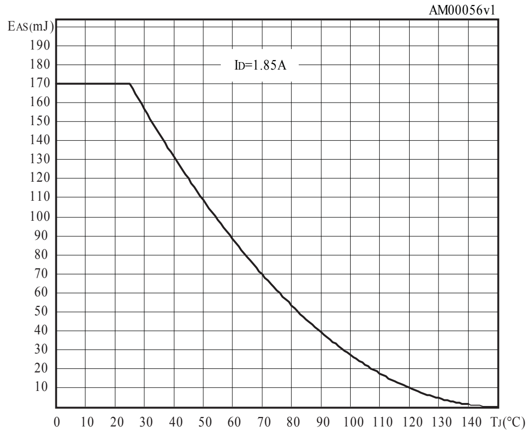


Figure 14. Maximum avalanche energy vs temperature

3 Test circuits

Figure 15. Test circuit for resistive load switching times

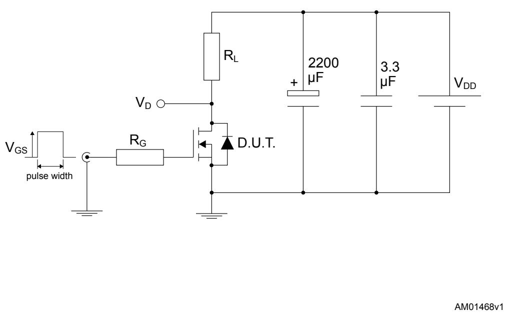


Figure 16. Test circuit for gate charge behavior

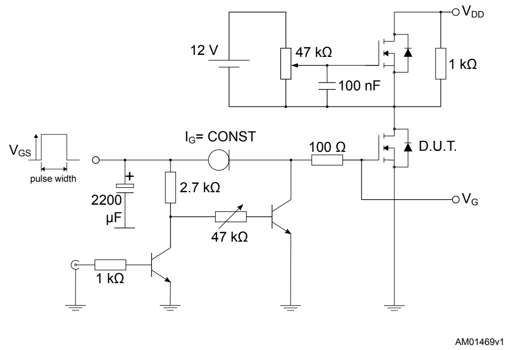


Figure 17. Test circuit for inductive load switching and diode recovery times

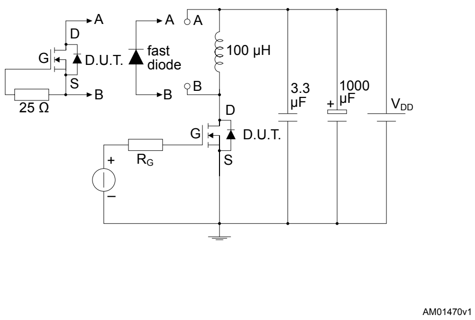


Figure 18. Unclamped inductive load test circuit

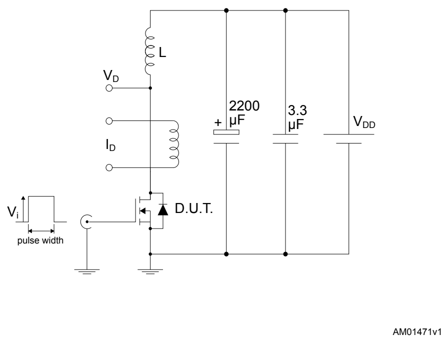


Figure 19. Unclamped inductive waveform

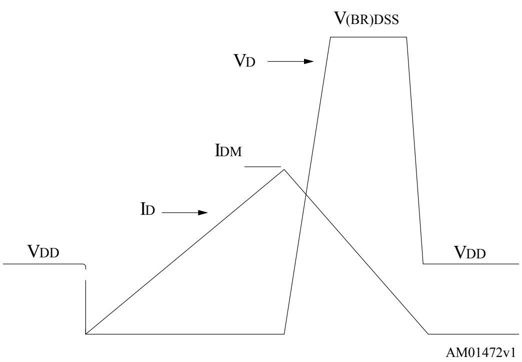
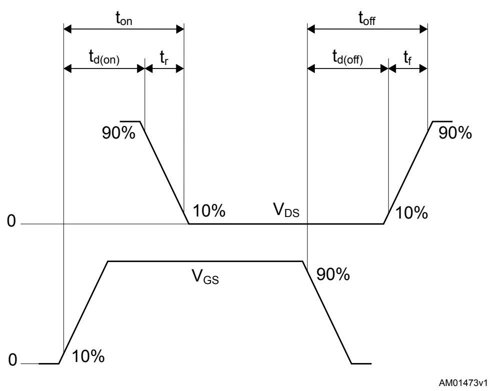


Figure 20. Switching time waveform



4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com. ECOPACK® is an ST trademark.

4.1 DPAK (TO-252) type A package information

Figure 21. DPAK (TO-252) type A package outline

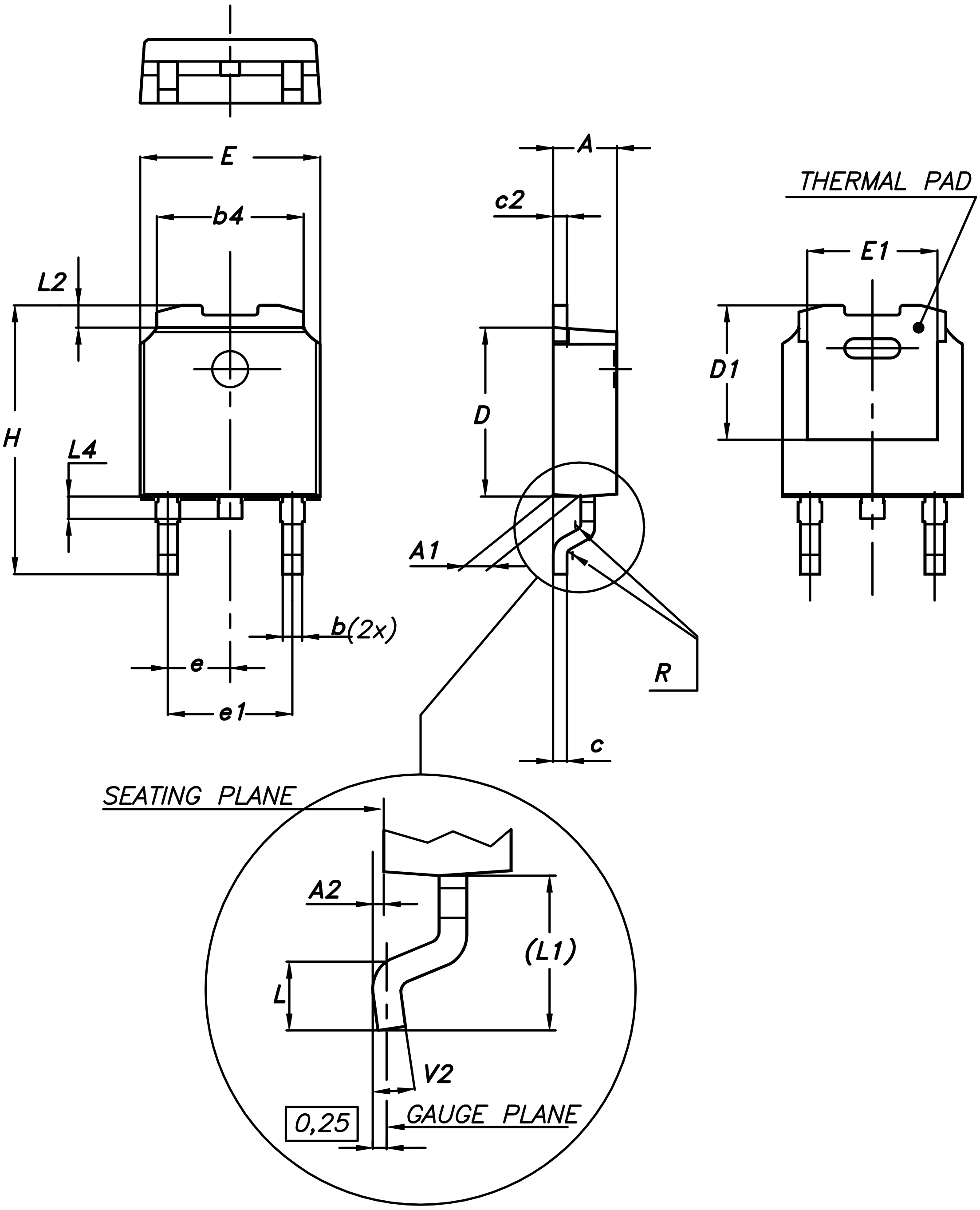


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Table 9. **DPAK (TO-252) type A mechanical data**

Dim.	mm		
	Min.	Typ.	Max.
A	2.20		2.40
A1	0.90		1.10
A2	0.03		0.23
b	0.64		0.90
b4	5.20		5.40
c	0.45		0.60
c2	0.48		0.60
D	6.00		6.20
D1	4.95	5.10	5.25
E	6.40		6.60
E1	4.60	4.70	4.80
e	2.159	2.286	2.413
e1	4.445	4.572	4.699
H	9.35		10.10
L	1.00		1.50
(L1)	2.60	2.80	3.00
L2	0.65	0.80	0.95
L4	0.60		1.00
R		0.20	
V2	0°		8°

4.2 DPAK (TO-252) type E package information

Figure 22. DPAK (TO-252) type E package outline

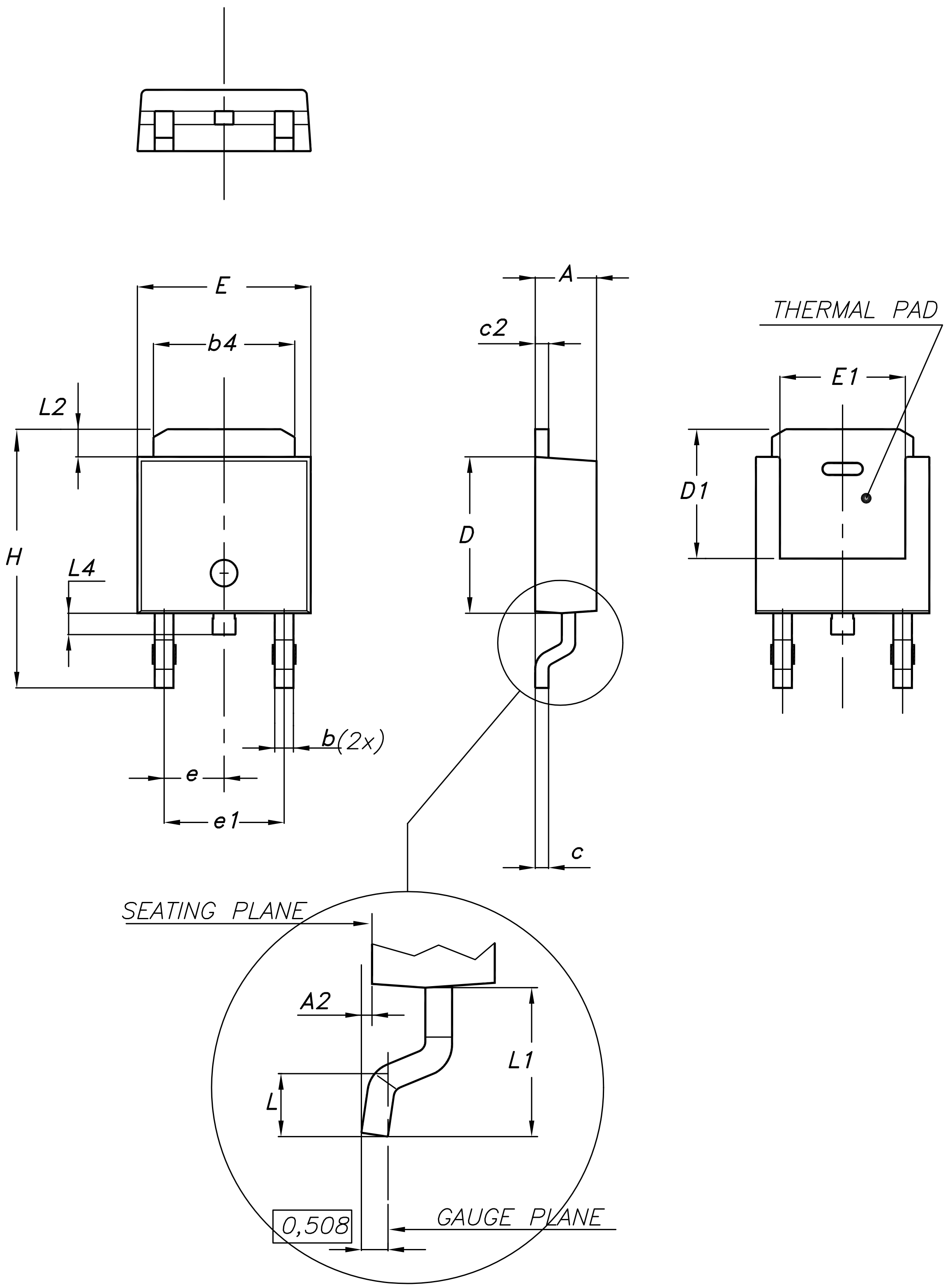

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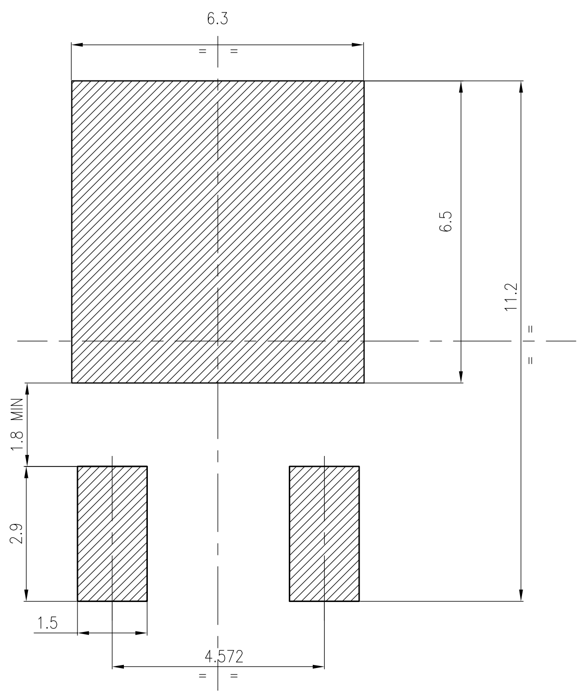
Table 10. **DPAK (TO-252) type E mechanical data**

Dim.	mm		
	Min.	Typ.	Max.
A	2.18		2.39
A2			0.13
b	0.65		0.884
b4	4.95		5.46
c	0.46		0.61
c2	0.46		0.60
D	5.97		6.22
D1	5.21		
E	6.35		6.73
E1	4.32		
e		2.286	
e1		4.572	
H	9.94		10.34
L	1.50		1.78
L1		2.74	
L2	0.89		1.27
L4			1.02

Figure 23. **DPAK (TO-252) recommended footprint (dimensions are in mm)**



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4.3 DPAK (TO-252) packing information

Figure 24. DPAK (TO-252) tape outline

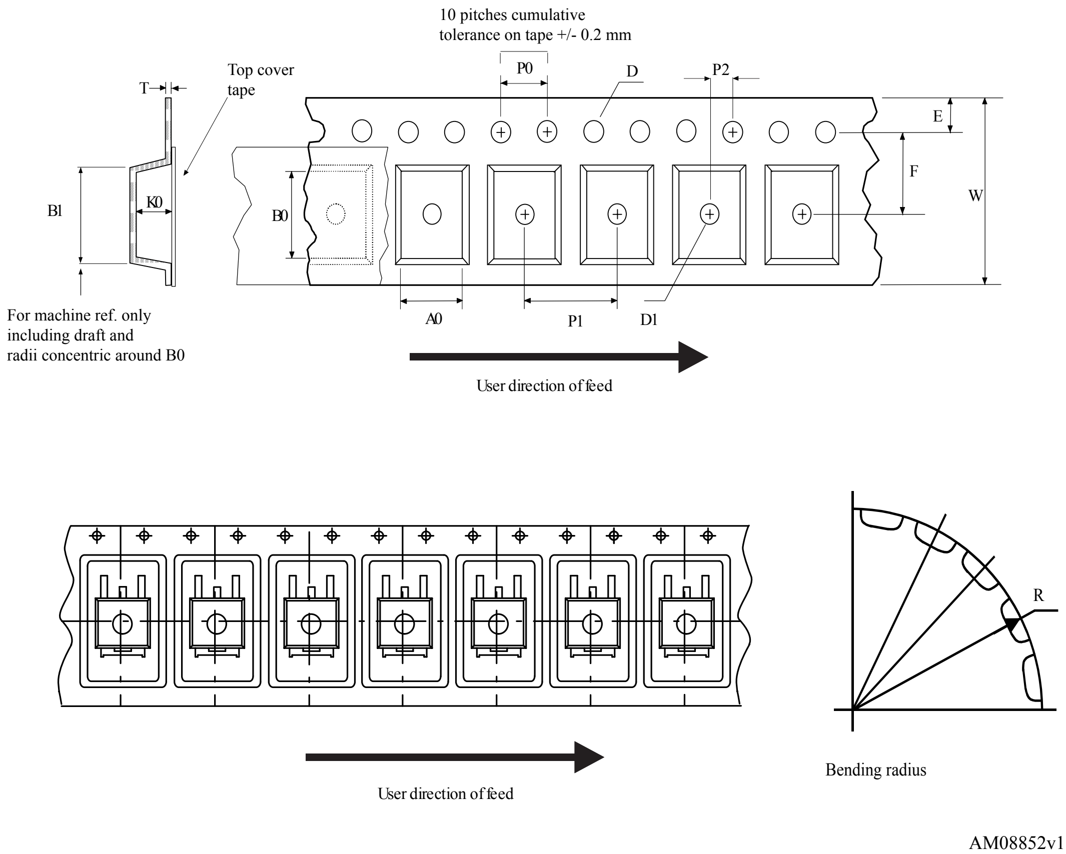

Figure 25. **DPAK (TO-252) reel outline**

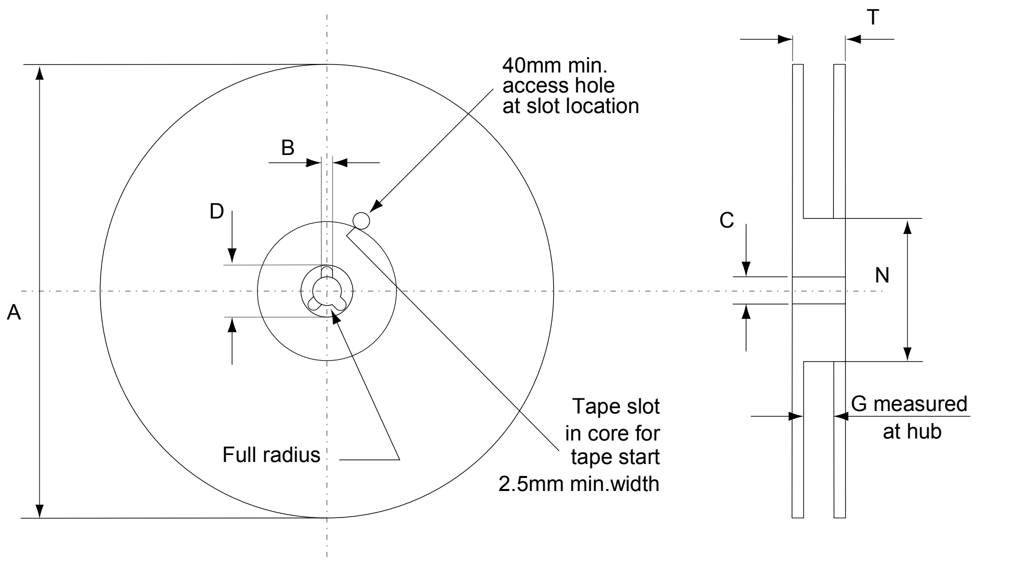

Table 11. **DPAK (TO-252) tape and reel mechanical data**

Tape			Reel		
Dim.	mm		Dim.	mm	
	Min.	Max.		Min.	Max.
A0	6.8	7	A		330
B0	10.4	10.6	B	1.5	
B1		12.1	C	12.8	13.2
D	1.5	1.6	D	20.2	
D1	1.5		G	16.4	18.4
E	1.65	1.85	N	50	
F	7.4	7.6	T		22.4
K0	2.55	2.75			
P0	3.9	4.1	Base qty.		2500
P1	7.9	8.1	Bulk qty.		2500
P2	1.9	2.1			
R	40				
T	0.25	0.35			
W	15.7	16.3			

4.4 TO-220 type A package information

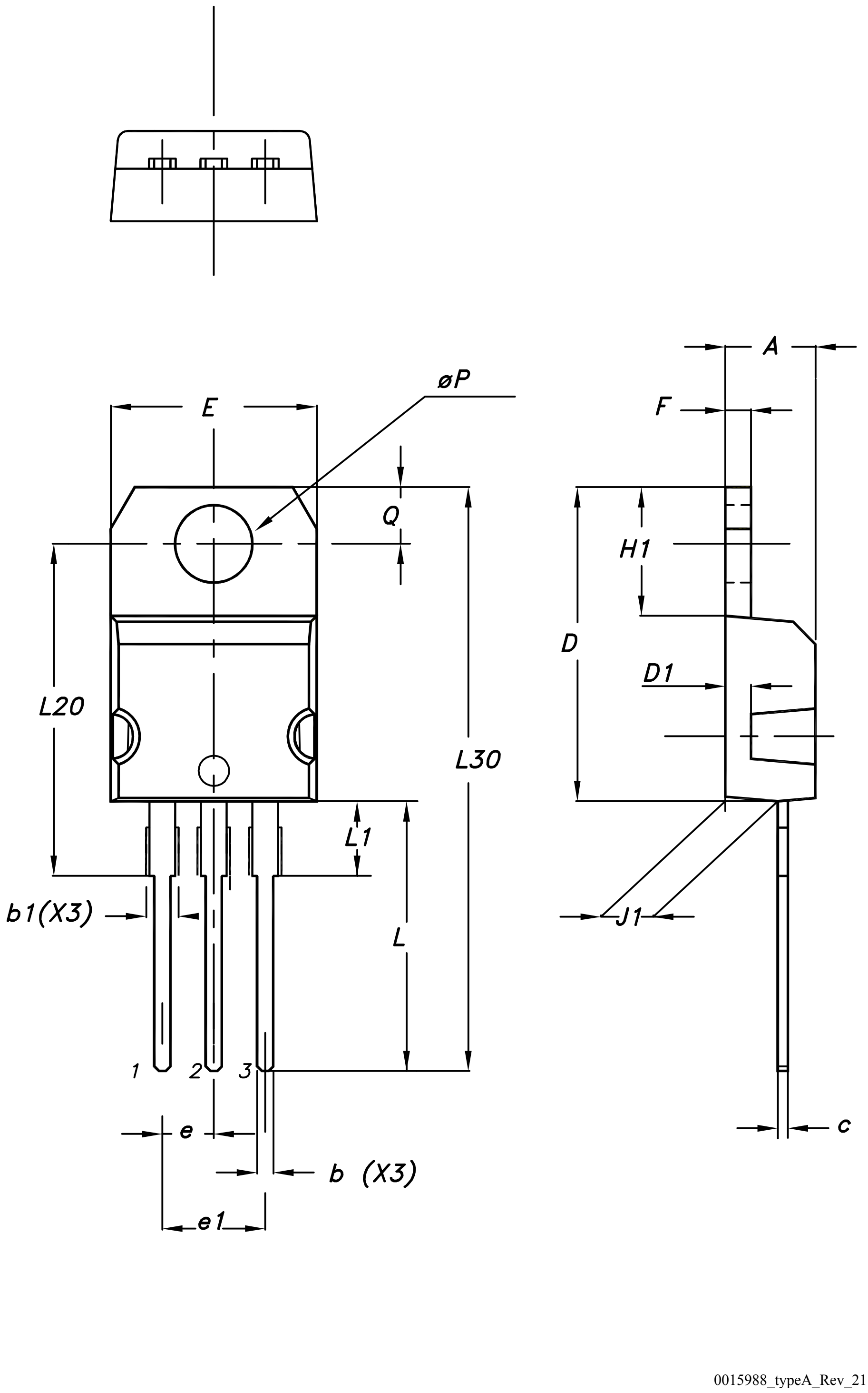

Figure 26. TO-220 type A package outline

Table 12. **TO-220 type A package mechanical data**

Dim.	mm		
	Min.	Typ.	Max.
A	4.40		4.60
b	0.61		0.88
b1	1.14		1.55
c	0.48		0.70
D	15.25		15.75
D1		1.27	
E	10.00		10.40
e	2.40		2.70
e1	4.95		5.15
F	1.23		1.32
H1	6.20		6.60
J1	2.40		2.72
L	13.00		14.00
L1	3.50		3.93
L20		16.40	
L30		28.90	
øP	3.75		3.85
Q	2.65		2.95

4.5 IPAK (TO-251) type A package information

Figure 27. **IPAK (TO-251) type A package outline**

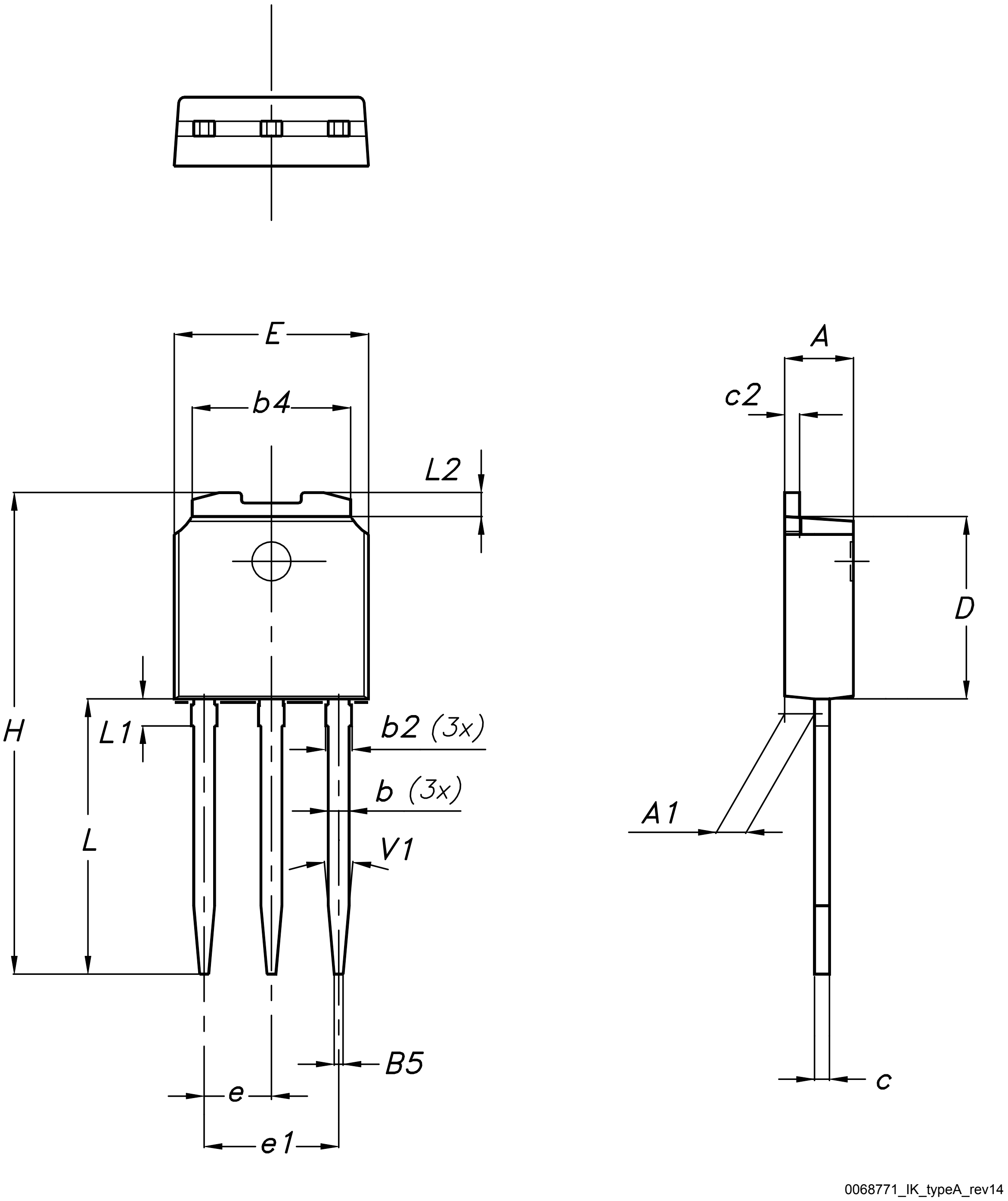

Table 13. **IPAK (TO-251) type A package mechanical data**

Dim.	mm		
	Min.	Typ.	Max.
A	2.20		2.40
A1	0.90		1.10
b	0.64		0.90
b2			0.95
b4	5.20		5.40
B5		0.30	
c	0.45		0.60
c2	0.48		0.60
D	6.00		6.20
E	6.40		6.60
e		2.28	
e1	4.40		4.60
H		16.10	
L	9.00		9.40
L1	0.80		1.20
L2		0.80	1.00
V1		10°	

5 Ordering information

Table 14. Order codes

Order code	Marking	Package	Packing
STD2NK100Z	2NK100Z	DPAK	Tape and reel
STP2NK100Z		TO-220	Tube
STU2NK100Z		IPAK	

Revision history

Table 15. **Document revision history**

Date	Version	Changes
24-Oct-2007	1	First release
18-Jun-2008	2	– Inserted new package, mechanical data IPAK – Document status promoted from preliminary data to datasheet.
28-Jun-2018	3	Removed maturity status indication from cover page. The document status is production data. Updated title in cover page, Section 1 Electrical ratings, Section 2 Electrical characteristics and Section 4 Package information. Minor text changes.

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